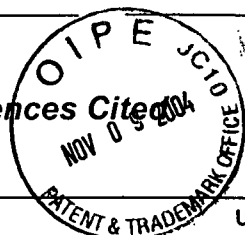


**Notice of References Cited**



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Applicant(s)/Patent Under  
Reexamination  
ARNOLD ET AL.

Examiner

Conrad J. DeWitte

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,564,217 B2	05-2003	Bunney et al.	707/10
	B	US-6,559,825 B2	05-2003	Jacobsen et al.	345/102
	C	US-6,430,624 B1	08-2002	Jamtgaard et al.	709/246
	D	US-6,266,684 B1	07-2001	Kraus et al.	715/513
	E	US-6,151,622 A	11-2000	Fraenkel et al.	709/205
	F	US-6,104,334 A	08-2000	Allport, David E.	341/175
	G	US-6,300,947 B1	10-2001	Kanevsky, Dimitri	345/866
	H	US-2002/0191031 A1	12-2002	Ricard, Gary Ross	345/838
	I	US-2002/0059244 A1	05-2002	Bunney et al.	707/10
	J	US-2002/0046886 A1	04-2002	Jones et al.	177/144
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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